

**Notice of References Cited**

Application/Control No.

09/673,381

Applicant(s)/Patent Under  
Reexamination  
OMURA ET AL.

Examiner

Yogesh K Aggarwal

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0080250	06-2002	OGAWA et al.	348/232
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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